

<b>Notice of References Cited</b>	Application/Control No. 10/808,793	Applicant(s)/Patent Under Reexamination HILL ET AL.	
	Examiner Victor V. Yevsikov	Art Unit 2891	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0098821 A1	05-2005	Chao et al.	257/314
	B	US-2003/0017711 A1	01-2003	Mahorowala et al.	438/719
	C	US-2005/0079706 A1	04-2005	Kumar et al.	438/638
	D	US-6,869,899 B2	03-2005	Mahorowala et al.	438/587
	E	US-2004/0178169 A1	09-2004	Desphande et al.	216/012
	F	US-6,461,984 B1	10-2002	Han et al.	438/788
	G	US-6,869,542 B2	03-2005	Desphande et al.	216/51
	H	US-6,893,938 B2	05-2005	Naeem et al.	438/424
	I	US-6,518,151 B1	02-2003	Dobuzinsky et al.	438/551
	J	US-6,835,662 B1	12-2004	Erhardt et al.	438/689
	K	US-6,780,708 B1	08-2004	Kinoshita et al.	438/241
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.